

4-Mbit (256K words × 16-bit) Static RAM with Error-Correcting Code (ECC)

Features

- High speed
 - $t_{AA} = 10 ns/15 ns$
- Embedded ECC for single-bit error correction^[1, 2]
- Low active and standby currents
 - □ Active current: I_{CC} = 38 mA typical
 - ☐ Standby current: I_{SB2} = 6 mA typical
- Operating voltage range: 1.65 V to 2.2 V, 2.2 V to 3.6 V, and 4.5 V to 5.5 V
- 1.0-V data retention
- TTL-compatible inputs and outputs
- Error indication (ERR) pin to indicate 1-bit error detection and correction
- Pb-free 44-pin SOJ, 44-pin TSOP II, and 48-ball VFBGA packages

Functional Description

CY7C1041G and CY7C1041GE are high-performance CMOS fast static RAM devices with embedded ECC. Both devices are offered in single chip-enable option and in multiple pin configurations. The CY7C1041GE device includes an ERR pin that signals an error-detection and correction event during a read cycle.

Data writes are performed by asserting the Chip Enable (\overline{CE}) and Write Enable (WE) inputs LOW, while providing the data on I/O $_0$ through I/O $_{15}$ and address on A $_0$ through A $_{17}$ pins. The Byte High Enable (BHE) and Byte Low Enable (BLE) inputs control write operations to the upper and lower bytes of the specified memory location. BHE controls I/O $_8$ through I/O $_{15}$ and BLE controls I/O $_0$ through I/O $_7$.

Data reads are performed by asserting the Chip Enable (CE) and Output Enable (\overline{OE}) inputs LOW and providing the required address on the address lines. Read data is accessible on the I/O lines (I/O₀ through I/O₁₅). Byte accesses can be performed by asserting the required byte enable signal (\overline{BHE} or \overline{BLE}) to read either the upper byte or the lower byte of data from the specified address location.

All I/Os (I/O $_0$ through I/O $_{15}$) are placed in a high-impedance state during the following events:

- The device is deselected (CE HIGH)
- The control signals (OE, BLE, BHE) are de-asserted

On the CY7C1041GE devices, the detection and correction of a single-bit error in the accessed location is indicated by the assertion of the ERR output (ERR = HIGH)^[1]. See the Truth Table on page 14 for a complete description of read and write modes.

The logic block diagram is on page 2.

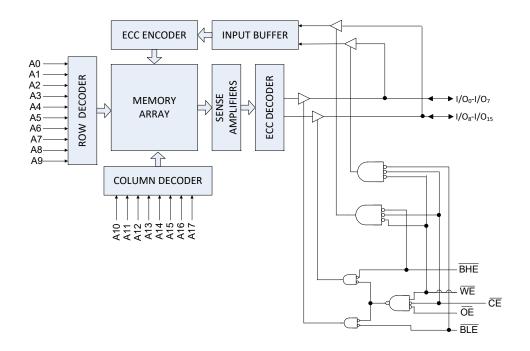
Product Portfolio

	Features and Options (see Pin Configurations on page 4)			Speed	Power Dissipation				
Product [3]		Range	V _{CC} Range	(ns)	Operating I _{CC} , (mA)		Standby, I _{SB2}		
Product			(V)	10/15	f = f _{max}		(mÅ)		
				10/13	Typ ^[4]	Max	Typ ^[4]	Max	
CY7C1041G(E)18	Single Chip Enable	Industrial	1.65 V-2.2 V	15	_	40	6	8	
CY7C1041G(E)30	Optional ERR pins		2.2 V-3.6 V	10	38	45			
CY7C1041G(E)			4.5 V–5.5 V	10	38	45			

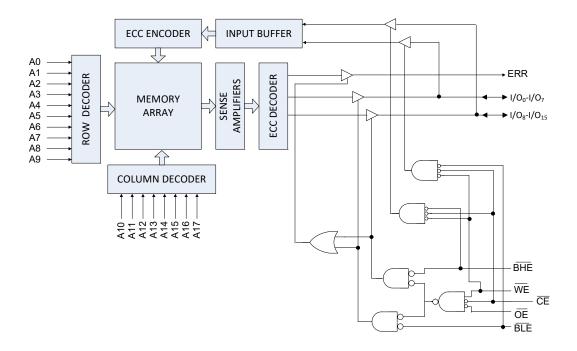
- 1. This device does not support automatic write-back on error detection.
- 2. SER FIT Rate <0.1 FIT/Mb. Refer AN88889 for details.
- 3. The ERR pin is available only for devices which have ERR option "E" in the ordering code. Refer Ordering Information on page 15 for details.
- Typical values are included only for reference and are not guaranteed or tested. Typical values are measured at V_{CC} = 1.8 V (for a V_{CC} range of 1.65 V-2.2 V), V_{CC} = 3 V (for a V_{CC} range of 2.2 V-3.6 V), and V_{CC} = 5 V (for a V_{CC} range of 4.5 V-5.5 V), T_A = 25 °C.



Logic Block Diagram - CY7C1041G



Logic Block Diagram - CY7C1041GE





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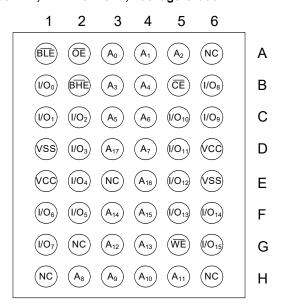
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Pin Configurations

Figure 1. 48-ball VFBGA (6 × 8 × 1.0 mm) Single Chip Enable Figure 2. 48-ball VFBGA (6 × 8 × 1.0 mm) Single Chip Enable without ERR, CY7C1041G $^{[5]}$, Package/Grade ID: BVXI $^{[7]}$ with ERR, CY7C1041GE $^{[5,6]}$, Package/Grade ID: BVXI $^{[7]}$



1 2 3 4 5 BLE ŌE (NC A₀ A_1 A_2 Α (I/O₀) (BHE) (A₃) A_4 (CE) (I/O₈) В C (I/O₁) (I/O₂) (I/O₁₀) (I/O₉) A₅ A_6 (vss) (I/O₃) (I/O₁₁ (vcc) D (A₁₇) A_7 (vcc) (I/O₄) (ERR) $\left(A_{16}\right)$ (I/O₁₂) (vss) Ε (I/O₆) (I/O₅) $\left(A_{14}\right)$ (A₁₅) (I/O₁₃) F (NC (WE) (I/O₇ (I/O₁₅ (A₁₂) (A₁₃) G (NC) (NC) A₈ A_9 (A₁₀ (A_{11}) Н

Figure 3. 48-ball VFBGA (6 × 8 × 1.0 mm) Single Chip Enable without ERR, CY7C1041G $^{[5]}$, Package/Grade ID: BVJXI $^{[7]}$

1 2 5 6 3 4 (BLE) (OE) (NC) A_0 A_1 $\left(A_{2}\right)$ Α (CE) (I/O₈) (BHE) (A₃) A₄ (I/O₀) В (I/O₁₀) (I/O₁) (I/O₂) С (A_5) A₆ (I/O₁₁) (I/O₃) (vcc) (A_{17}) $\left(A_{7}\right)$ D (A₁₆) (I/O₁₂) (NC) (I/O₄) (vss) Ε (I/O₁₃) (I/O₅) (I/O₆) (I/O₁₄) (A_{15}) (A_{14}) F (A_{13}) (NC (WE (I/O₇) (A_{12}) G (NC) (NC A_8 A₁₁ A₁₀ Η

Figure 4. 48-ball VFBGA (6 × 8 × 1.0 mm) Single Chip Enable with ERR, CY7C1041GE $^{[5, 6]}$, Package/Grade ID: BVJXI $^{[7]}$

_	1	2	3	4	5	6	_
	BLE	(OE)	\bigcirc A ₀	\bigcirc A ₁	\bigcirc A ₂	NC	Α
	(I/O ₈)	BHE	\bigcirc A ₃	$\overbrace{A_4}$	$\overline{\widehat{CE}}$	(I/O ₀)	В
	(I/O ₉)	(I/O ₁₀)	\bigcirc A ₅	\bigcirc A ₆	(I/O_1)	(I/O ₂)	С
	vss	(I/O ₁₁)	$\left(A_{17}\right)$	\bigcirc A ₇	(I/O ₃)	(VCC)	D
	vcc	(I/O ₁₂)	ERR	(A ₁₆)	(I/O ₄)	vss	E
	(I/O ₁₄)	(I/O ₁₃)	$\left(A_{14} \right)$	(A ₁₅)	(I/O ₅)	(I/O ₆)	F
	(I/O ₁₅)	(NC)	$\left(A_{12} \right)$	$\left(A_{13}\right)$	WE	(I/O ₇)	G
	NC	\bigcirc A ₈	\bigcirc A ₉	$\left(A_{10}\right)$	$\left(A_{11}\right)$	NC	Н
_							_

- 5. NC pins are not connected internally to the die.
- 6. ERR is an output pin.
- Package type BVJXI is JEDEC compliant compared to package type BVXI. The difference between the two is that the higher and lower byte I/Os (I/O_[7:0] and I/O_[15:8] balls are swapped.



Pin Configurations (continued)

Figure 5. 44-pin TSOP II/44-pin SOJ Single Chip Enable with ERR, CY7C1041GE [8, 9]

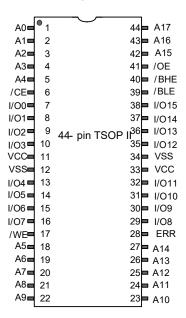
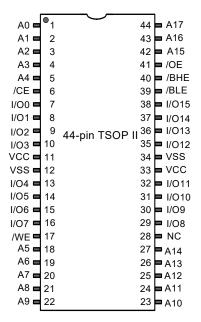


Figure 6. 44-pin TSOP II/44-pin SOJ Single Chip Enable without ERR, CY7C1041G [8]



- 8. NC pins are not connected internally to the die.
- 9. ERR is an output pin.



Maximum Ratings

DC input voltage [10]	0.5 V to V _{CC} + 0.5 V
Current into outputs (in LOW state)	20 mA
Static discharge voltage	
(MIL-STD-883, Method 3015)	>2001 V
Latch-up current	> 140 mA

Operating Range

Grade	Ambient Temperature	V _{CC}
Industrial	–40 °C to +85 °C	1.65 V to 2.2 V, 2.2 V to 3.6 V, 4.5 V to 5.5 V

DC Electrical Characteristics

Over the operating range of -40 °C to 85 °C

Doromotor	arameter Description Test Conditions		Tost Conditions		1	0 ns/15 n	S	Unit
Parameter			ns	Min	Typ [11]	Max	Unit	
V _{OH}	Output HIGH	1.65 V to 2.2 V	V_{CC} = Min, I_{OH} = -0.1 m.	A	1.4	_	_	V
	voltage	2.2 V to 2.7 V	V _{CC} = Min, I _{OH} = -1.0 m.	A	2	_	-	
		2.7 V to 3.0 V	V _{CC} = Min, I _{OH} = -4.0 m	A	2.2	_	-	
		3.0 V to 3.6 V	V _{CC} = Min, I _{OH} = -4.0 m.	A	2.4	_	_	
		4.5 V to 5.5 V	V _{CC} = Min, I _{OH} = -4.0 m	A	2.4	_	-	
		4.5 V to 5.5 V	V _{CC} = Min, I _{OH} = -0.1 m	A	$V_{CC} - 0.5^{[12]}$	_	_	
V _{OL}	Output LOW	1.65 V to 2.2 V	V _{CC} = Min, I _{OL} = 0.1 mA		_	-	0.2	V
	voltage	2.2 V to 2.7 V	V _{CC} = Min, I _{OL} = 2 mA		_	-	0.4	
		2.7 V to 3.6 V	V _{CC} = Min, I _{OL} = 8 mA		_	-	0.4	
		4.5 V to 5.5 V	V _{CC} = Min, I _{OL} = 8 mA		_	-	0.4	
V _{IH}	V _{IH} Input HIGH	1.65 V to 2.2 V	-		1.4	_	$V_{CC} + 0.2^{[10]}$	V
	voltage	2.2 V to 2.7 V	-		2	-	$V_{CC} + 0.3^{[10]}$	
		2.7 V to 3.6 V	-		2	-	$V_{CC} + 0.3^{[10]}$	
		4.5 V to 5.5 V	-		2	-	V _{CC} + 0.5 [10]	
V_{IL}	Input LOW	1.65 V to 2.2 V	-		-0.2 ^[10]	_	0.4	V
	voltage	2.2 V to 2.7 V	-		-0.3 ^[10]	_	0.6	
		2.7 V to 3.6 V	-		-0.3 ^[10]	_	0.8	
		4.5 V to 5.5 V	-		-0.5 ^[10]	_	0.8	
I _{IX}	Input leakage c	urrent	$GND \le V_{IN} \le V_{CC}$		-1	_	+1	μΑ
I _{OZ}	Output leakage	current	GND \leq V _{OUT} \leq V _{CC} , Out	put disabled	-1	-	+1	μΑ
I _{CC}			Max V _{CC} , I _{OUT} = 0 mA, CMOS levels	f = 100 MHz	_	38	45	mA
			CMOS levels	f = 66.7 MHz	_	_	40	
I _{SB1}	Automatic CE power-down current – TTL inputs		$\begin{array}{l} \text{Max V}_{\text{CC}}, \overline{\text{CE}} \geq \text{V}_{\text{IH}}, \\ \text{V}_{\text{IN}} \geq \text{V}_{\text{IH}} \text{ or V}_{\text{IN}} \leq \text{V}_{\text{IL}}, \text{f} = \\ \end{array}$	f _{MAX}	_	ı	15	mA
I _{SB2}	Automatic CE p current – CMO	oower-down S inputs	$\begin{array}{c} \text{Max V}_{\text{CC}}, \overline{\text{CE}} \geq \text{V}_{\text{CC}} - 0. \\ \text{V}_{\text{IN}} \geq \text{V}_{\text{CC}} - 0.2 \text{ V or V}_{\text{IN}} \end{array}$		_	6	8	mA

^{10.} $V_{IL(min)}$ = -2.0 V and $V_{IH(max)}$ = V_{CC} + 2 V for pulse durations of less than 20 ns.

^{11.} Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at V_{CC} = 1.8 V (for V_{CC} range of 1.65 V – 2.2 V), V_{CC} = 3 V (for V_{CC} range of 2.2V – 3.6 V), and V_{CC} = 5 V (for V_{CC} range of 4.5 V – 5.5 V), V_{CC} = 3 V (for V_{CC} range of 2.2V – 3.6 V), and V_{CC} = 5 V (for V_{CC} range of 4.5 V – 5.5 V), V_{CC} = 25 °C.

^{12.} This parameter is guaranteed by design and not tested.



Capacitance

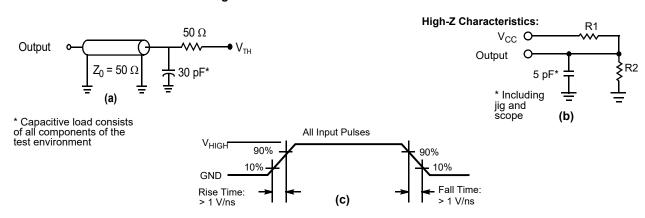
Parameter [13]	Description	Test Conditions	48-ball VFBGA	44-pin SOJ	44-pin TSOP II	Unit
C _{IN}	' '	T _A = 25 °C, f = 1 MHz,	10	10	10	pF
C _{OUT}	I/O capacitance	$V_{CC} = V_{CC(typ)}$	10	10	10	pF

Thermal Resistance

Parameter [13]	Description	Test Conditions	48-ball VFBGA	44-pin SOJ	44-pin TSOP II	Unit
Θ_{JA}	(junction to ambient)	Still air, soldered on a 3 × 4.5 inch, four-layer	31.35	55.37	68.85	°C/W
$\Theta_{\sf JC}$	Thermal resistance (junction to case)	printed circuit board	14.74	30.41	15.97	°C/W

AC Test Loads and Waveforms

Figure 7. AC Test Loads and Waveforms [14]



Parameters	1.8 V	3.0 V	5.0 V	Unit
R1	1667	317	317	Ω
R2	1538	351	351	Ω
V _{TH}	0.9	1.5	1.5	V
V _{HIGH}	1.8	3	3	V

^{13.} Tested initially and after any design or process changes that may affect these parameters.

^{14.} Full-device AC operation assumes a 100- μ s ramp time from 0 to $V_{CC(min)}$ and a 100- μ s wait time after V_{CC} stabilization.



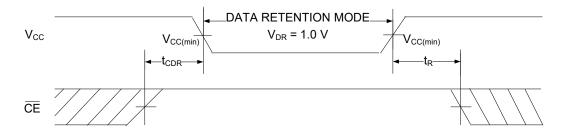
Data Retention Characteristics

Over the operating range of -40 °C to 85 °C

Parameter	Description	Conditions	Min	Max	Unit
V_{DR}	V _{CC} for data retention		1	_	V
I _{CCDR}	Data retention current	$V_{CC} = 1.2 \text{ V}, \overline{CE} \ge V_{CC} - 0.2 \text{ V}^{[15]},$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}, \text{ or } V_{IN} \le 0.2 \text{ V}$	-	8	mA
t _{CDR} ^[16]	Chip deselect to data retention time		0	_	ns
t _R ^[15, 16]	Operation recovery time	V _{CC} ≥ 2.2 V	10	ı	ns
		V _{CC} < 2.2 V	15	_	ns

Data Retention Waveform

Figure 8. Data Retention Waveform [15]



^{15.} Full-device operation requires linear V_{CC} ramp from V_{DR} to $V_{CC(min)} \ge 100 \, \mu s$ or stable at $V_{CC \, (min)} \ge 100 \, \mu s$.

^{16.} These parameters are guaranteed by design.



AC Switching Characteristics

Over the operating range of -40 °C to 85 °C

D [17]	B	10) ns	15	11!4	
Parameter [17]	Description	Min	Max	Min	Max	Unit
Read Cycle		•	•	•	•	•
t _{RC}	Read cycle time	10	_	15	_	ns
t _{AA}	Address to data / ERR valid	_	10	_	15	ns
t _{OHA}	Data / ERR hold from address change	3	-	3	_	ns
t _{ACE}	CE LOW to data / ERR valid	_	10	-	15	ns
t _{DOE}	OE LOW to data / ERR valid	_	4.5	_	8	ns
t _{LZOE}	OE LOW to low impedance ^[18]	0	-	0	_	ns
t _{HZOE}	OE HIGH to HI-Z [18, 19]	_	5	_	8	ns
t _{LZCE}	CE LOW to low impedance [18]	3	-	3	-	ns
t _{HZCE}	CE HIGH to HI-Z [18, 19]	_	5	_	8	ns
t _{PU}	CE LOW to power-up [19, 18]	0	-	0	-	ns
t _{PD}	CE HIGH to power-down [19, 18]	_	10	_	15	ns
t _{DBE}	Byte enable to data valid	_	4.5	_	8	ns
t _{LZBE}	Byte enable to low impedance ^[18]	0	_	0	_	ns
t _{HZBE}	Byte disable to HI-Z ^[19]	_	6	_	8	ns
Write Cycle [2	0, 21]					
t_{WC}	Write cycle time	10	_	15	_	ns
t _{SCE}	CE LOW to write end	7	_	12	_	ns
t _{AW}	Address setup to write end	7	_	12	_	ns
t _{HA}	Address hold from write end	0	-	0	-	ns
t _{SA}	Address setup to write start	0	_	0	_	ns
t _{PWE}	WE pulse width	7	_	12	_	ns
t _{SD}	Data setup to write end	5	_	8	_	ns
t _{HD}	Data hold from write end	0	-	0	_	ns
t _{LZWE}	WE HIGH to low impedance [18]	3	-	3	_	ns
t _{HZWE}	WE LOW to HI-Z [19]		5	_	8	ns
t _{BW}	Byte Enable to write end	7	-	12	_	ns

^{17.} Test conditions assume a signal transition time (rise/fall) of 3 ns or less, timing reference levels of 1.5 V (for $V_{CC} \ge 3$ V) and $V_{CC}/2$ (for $V_{CC} < 3$ V), and input pulse levels of 0 to 3 V (for $V_{CC} \ge 3$ V) and 0 to V_{CC} (for $V_{CC} < 3$ V). Test conditions for the read cycle use output loading, as shown in part (a) of Figure 7 on page 7, unless specified otherwise

^{18.} t_{HZOE}, t_{HZCE}, t_{HZWE}, t_{HZBE}, t_{LZOE}, t_{LZCE}, t_{LZWE}, and t_{LZBE} are specified with a load capacitance of 5 pF, as shown in part (b) of Figure 7 on page 7. Transition is measured ±200 mV from

^{19.} These parameters are guaranteed by design and are not tested.

^{20.} The internal write time of the memory is defined by the overlap of WE = V_{IL}, CE = V_{IL}, and BHE or BLE = V_{IL}. These signals must be LOW to initiate a write, and the HIGH transition of any of these signals can terminate the operation. The input data setup and hold timing should be referenced to the edge of the signal that terminates

^{21.} The minimum write cycle pulse width in Write Cycle No 2 (WE Controlled, OE LOW) should be equal to sum of t_{sd}and t_{HZWE}.



Switching Waveforms

Figure 9. Read Cycle No. 1 of CY7C1041G (Address Transition Controlled) $^{[22,\,23]}$

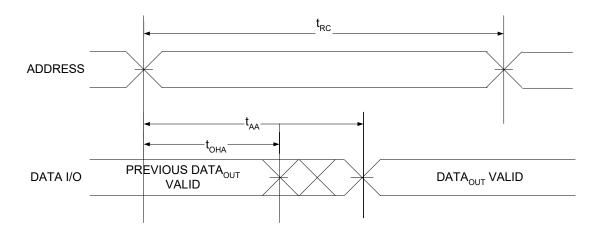
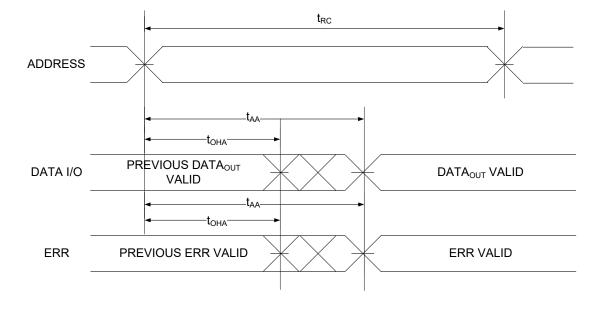


Figure 10. Read Cycle No. 1 of CY7C1041GE (Address Transition Controlled) [22, 23]

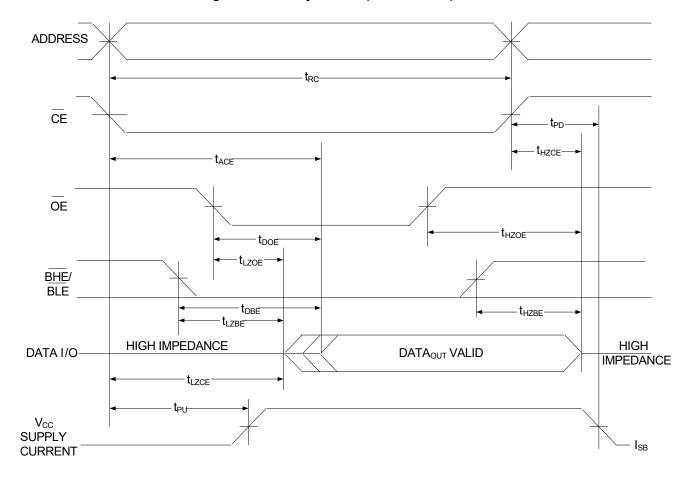


Notes22. The device is continuously selected, $\overline{OE} = V_{IL}$, $\overline{CE} = V_{IL}$, \overline{BHE} or \overline{BLE} or both = V_{IL} .
23. \overline{WE} is HIGH for the read cycle.



Switching Waveforms (continued)

Figure 11. Read Cycle No. 2 (OE Controlled) [24, 25]



Notes

24. WE is HIGH for the read cycle.

25. Address valid prior to or coincident with CE LOW transition.



Switching Waveforms (continued)

Figure 12. Write Cycle No. 1 (CE Controlled) [26, 27]

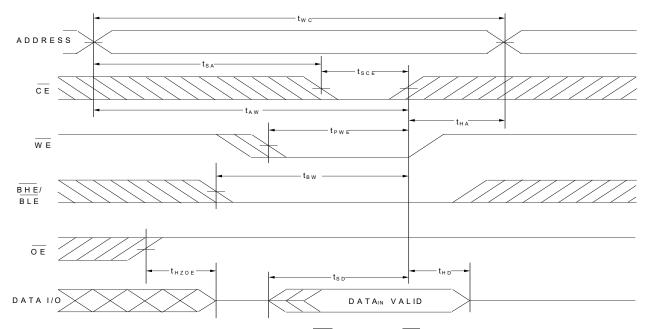
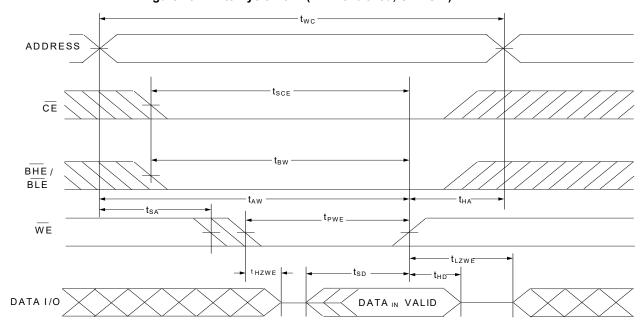


Figure 13. Write Cycle No. 2 ($\overline{\text{WE}}$ Controlled, $\overline{\text{OE}}$ LOW) $^{[26,\ 27,\ 28]}$



- 26. The internal write time of the memory is defined by the overlap of WE = V_{IL}, \(\overline{CE} = V_{IL}\), and \(\overline{BHE}\) or \(\overline{BLE} = V_{IL}\). These signals must be LOW to initiate a write, and the HIGH transition of any of these signals can terminate the operation. The input data setup and hold timing should be referenced to the edge of the signal that terminates the write.
- 27. Data I/O is in HI-Z state if $\overline{CE} = V_{IH}$, or $\overline{OE} = V_{IH}$, or \overline{BHE} , and/or $\overline{BLE} = V_{IH}$.
- 28. The minimum write cycle pulse width should be equal to sum of t_{SD} and t_{HZWE} .



Switching Waveforms (continued)

ADDRESS
ADDRES

Figure 15. Write Cycle No. 4 ($\overline{\text{WE}}$ Controlled) [29, 30, 31] **ADDRESS** t_{SCE} CE₁ t_{AW} t_{HA} t_{SA} t_{PWE} WE t_{BW} BHE/BLE OE t_{HD} t_{SD} NOTE 32 DATA I/O DATA IN VALID

- 29. The internal write time of the memory is defined by the overlap of WE = V_{IL}, CE = V_{IL}, and BHE or BLE = V_{IL}. These signals must be LOW to initiate a write, and the HIGH transition of any of these signals can terminate the operation. The input data setup and hold timing should be referenced to the edge of the signal that terminates the write.
- 30. Data I/O is in HI-Z state if $\overline{\text{CE}} = V_{\text{IH}}$, or $\overline{\text{OE}} = V_{\text{IH}}$, or $\overline{\text{BHE}}$, and/or $\overline{\text{BLE}} = V_{\text{IH}}$.
- 31. Data I/O is high impedance if $\overline{OE} = V_{IH}$.
- 32. During this period the I/Os are in output state. Do not apply input signals.



Truth Table

CE	OE	WE	BLE	BHE	I/O ₀ –I/O ₇	I/O ₈ -I/O ₁₅	Mode	Power
Н	X ^[33]	X ^[33]	X ^[33]	X ^[33]	HI-Z	HI-Z	Power down	Standby (I _{SB})
L	Г	Н	L	L	Data out	Data out	Read all bits	Active (I _{CC})
L	L	Н	Г	Н	Data out	HI-Z	Read lower bits only	Active (I _{CC})
L	L	Н	Н	L	HI-Z	Data out	Read upper bits only	Active (I _{CC})
L	Х	L	L	L	Data in	Data in	Write all bits	Active (I _{CC})
L	Х	L	L	Н	Data in	HI-Z	Write lower bits only	Active (I _{CC})
L	Х	L	Н	L	HI-Z	Data in	Write upper bits only	Active (I _{CC})
L	Η	Н	Χ	X	HI-Z	HI-Z	Selected, outputs disabled	Active (I _{CC})
L	Х	Х	Ι	Н	HI-Z	HI-Z	Selected, outputs disabled	Active (I _{CC})

ERR Output - CY7C1041GE

Output [34]	Mode
0	Read operation, no single-bit error in the stored data.
1	Read operation, single-bit error detected and corrected.
HI-Z	Device deselected or outputs disabled or Write operation

 $\begin{array}{l} \textbf{Notes} \\ 33.\,\text{The input voltage levels on these pins should be either at V}_{\text{IH}}\,\text{or V}_{\text{IL}}. \\ 34.\,\text{ERR is an Output pin.If not used, this pin should be left floating.} \end{array}$

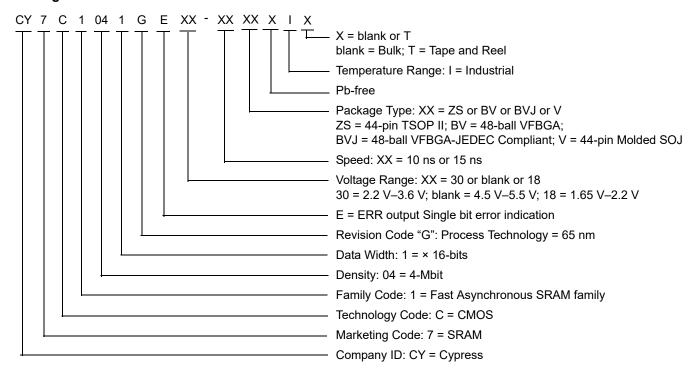


Ordering Information

Speed (ns)	Voltage Range	Ordering Code	Package Diagram	Package Type (all Pb-free)	Operating Range
10	2.2 V-3.6 V	CY7C1041GE30-10ZSXI	51-85087	44-pin TSOP II, ERR output	Industrial
		CY7C1041GE30-10ZSXIT	51-85087	44-pin TSOP II, ERR output, Tape and Reel	,
		CY7C1041G30-10ZSXI	C1041G30-10ZSXI 51-85087 44-pin TSOP II		
		CY7C1041G30-10ZSXIT	51-85087	44-pin TSOP II, Tape and Reel	
		CY7C1041GE30-10BVXI	51-85150	48-ball VFBGA (6 × 8 × 1.0 mm), ERR output	
		Y7C1041GE30-10BVXIT 51-85150 48-ball VFBGA (6 × 8 × 1.0 mm), ERR output, Tape and Reel			
		CY7C1041G30-10BVXI	51-85150	48-ball VFBGA (6 × 8 × 1.0 mm)	
		CY7C1041G30-10BVXIT	51-85150	48-ball VFBGA (6 × 8 × 1.0 mm), Tape and Reel	
		CY7C1041G30-10BVJXI	51-85150	48-ball VFBGA (6 × 8 × 1.0 mm), JEDEC	
		CY7C1041G30-10BVJXIT	51-85150	48-ball VFBGA (6 × 8 × 1.0 mm), JEDEC, Tape and Reel	
		CY7C1041G30-10VXI	51-85082	44-pin SOJ (400 Mils)	
		CY7C1041G30-10VXIT	51-85082	44-pin SOJ (400 Mils), Tape and Reel	
		CY7C1041GE30-10VXI	51-85082	44-pin SOJ (400 Mils), ERR output	
		CY7C1041GE30-10VXIT 51-85082 44-pin SOJ (400 Mils), ERR output, Tape and Reel			
	4.5 V–5.5 V	CY7C1041G-10ZSXI	·		
		CY7C1041G-10ZSXIT			
		CY7C1041GE-10ZSXI	51-85087	44-pin TSOP II, ERR output	
		CY7C1041GE-10ZSXIT	51-85087	44-pin TSOP II, ERR output, Tape and Reel	
		CY7C1041GE-10VXI	51-85082	44-pin SOJ (400 Mils), ERR output	
		CY7C1041GE-10VXIT	51-85082	44-pin SOJ (400 Mils), ERR output, Tape and Reel	
		CY7C1041G-10VXI	51-85082	44-pin SOJ (400 Mils)	
		CY7C1041G-10VXIT	51-85082	44-pin SOJ (400 Mils), Tape and Reel	
15	1.65 V-2.2 V	CY7C1041G18-15ZSXI	51-85087	44-pin TSOP II	
		CY7C1041G18-15ZSXIT	51-85087	44-pin TSOP II, Tape and Reel	
		CY7C1041G18-15VXI	51-85082	44-pin SOJ (400 Mils)	
		CY7C1041G18-15VXIT	51-85082	44-pin SOJ (400 Mils), Tape and Reel	
		CY7C1041G18-15BVXI	51-85150	48-ball VFBGA (6 × 8 × 1.0 mm)	
		CY7C1041G18-15BVXT	51-85150	48-ball VFBGA (6 × 8 × 1.0 mm), Tape and Reel	



Ordering Code Definitions





Package Diagrams

Figure 16. 44-pin TSOP II (Z44) Package Outline, 51-85087

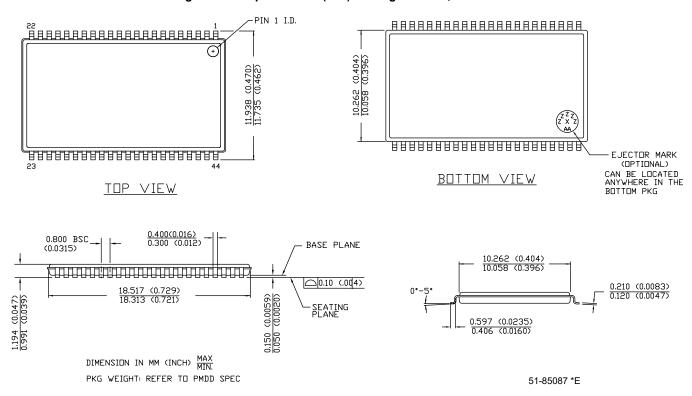
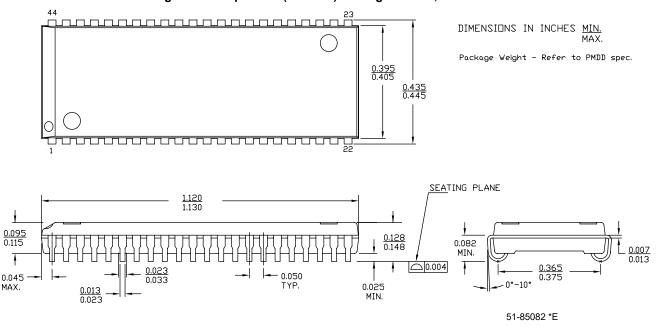


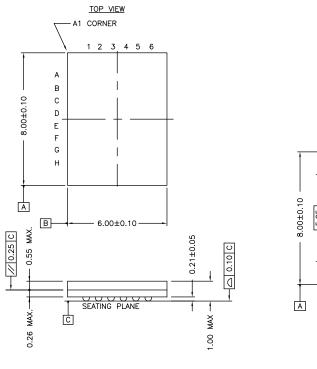
Figure 17. 44-pin SOJ (400 Mils) Package Outline, 51-85082

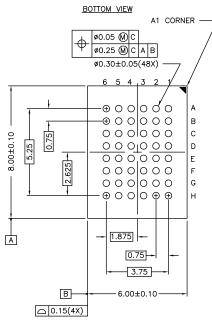




Package Diagrams (continued)

Figure 18. 48-ball VFBGA (6 × 8 × 1.0 mm) BV48/BZ48 Package Outline, 51-85150





NOTE:
PACKAGE WEIGHT: See Cypress Package Material Declaration Datasheet (PMDD)
posted on the Cypress web.

51-85150 *H



Acronyms

Acronym	Description
BHE	byte high enable
BLE	byte low enable
CE	chip enable
CMOS	complementary metal oxide semiconductor
I/O	input/output
ŌĒ	output enable
SRAM	static random access memory
TSOP	thin small outline package
TTL	transistor-transistor logic
VFBGA	very fine-pitch ball grid array
WE	write enable

Document Conventions

Units of Measure

Symbol	Unit of Measure			
°C	Degrees Celsius			
MHz	megahertz			
μΑ	microamperes			
μS	microseconds			
mA	milliamperes			
mm	millimeters			
ns	nanoseconds			
Ω	ohms			
%	percent			
pF	picofarads			
V	volts			
W	watts			



Document History Page

Document Title: CY7C1041G/CY7C1041GE, 4-Mbit (256K words × 16-bit) Static RAM with Error-Correcting Code (ECC) Document Number: 001-91368				
Rev.	ECN No.	Orig. of Change	Submission Date	Description of Change
*F	4867081	NILE	07/31/2015	Changed status from Preliminary to Final.
*G	4876251	NILE	08/07/2015	Updated Ordering Information: Updated part numbers.
*H	4968879	NILE	10/16/2015	Fixed typo in bookmarks.
*	5019226	VINI	11/18/2015	Updated Ordering Information: Updated part numbers.
*J	5122043	NILE	02/02/2016	Updated Truth Table.
*K	5223335	NILE	08/30/2016	Updated DC Electrical Characteristics: Removed values of V _{OH} parameter corresponding to "2.7 V to 3.6 V" range. Added values of V _{OH} parameter corresponding to "2.7 V to 3.0 V" and "3.0 V to 3.6 V" ranges. Updated Note 10 (Replaced "2 ns" with "20 ns"). Updated Ordering Information: Updated part numbers. Updated to new template.
*L	5655218	NILE	03/09/2017	Updated Logic Block Diagram – CY7C1041G (Updated diagram to change the devices from Dual Chip enabled to Single Chip enabled). Updated Logic Block Diagram – CY7C1041GE (Updated diagram to change the devices from Dual Chip enabled to Single Chip enabled). Updated to new template.
*M	5731242	GNKK	05/09/2017	Updated logo and copyright. Completing Sunset Review.
*N	6245720	NILE	07/13/2018	Updated Features: Added Note 2 and referred the same note in "Embedded ECC for single-bit error correction". Updated to new template. Completing Sunset Review.



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